

VNIIA. Exam Schedule

Mon, 23 Dec	11:55 — 13:30	TEST	Materials science and modern technologies in engineering	 M18-621
			Nevskiy R.E.	
Mon, 23 Dec	14:30 — 16:05	ATT	Microprocessor technology	 M18-621  Benesh P.B.
Tue, 24 Dec	10:15 — 11:50	TEST	Academic (Research) Practice:	 M19-601, M19-681  Sidorov A.V., Maksimkin A.I.
Tue, 24 Dec	12:45 — 14:20	TEST	Basic Metrology and Measurment Errors	 M19-681  Ryabeva E.V.
Wed, 25 Dec	10:15 — 11:50	ATT	Construction (part 2)	 M18-621  Ushkov A.V., Yakubov R.H.
Wed, 25 Dec	12:45 — 14:20	ATT	Thermal fields in the device engineering, thermal exposure and testing	 M18-621  Antropov D.S.
Wed, 25 Dec	14:30 — 16:05	TEST	Electronics and Circuit Design	 M19-681  Maksimkin A.I., Schepeliev R.M.
Wed, 25 Dec	16:15 — 17:50	TEST	Computer Technology	 M19-601, M19-681  Novikov A.B., Abramova A.Y.
Fri, 27 Dec	09:20 — 11:00	ATT	Principles of Complex Technical Systems Design. Standardization and Systems of Quality Assurance.	 M19-601  Ulyanin O.V., Erofeeva T.K.
Fri, 27 Dec	12:45 — 14:20	ATT	Methods of complex technical systems development. Standardization and quality assurance systems.	 M19-681  Erofeeva T.K., Ulyanin O.V.
Fri, 10 Jan	09:00 — 13:00	EXAM	Construction (part 2)	 M18-621  Ushkov A.V., Yakubov R.H.
Fri, 17 Jan	09:00 — 13:00	EXAM	Methods of complex technical systems development. Standardization and quality assurance systems.	 M19-681  Ulyanin O.V., Erofeeva T.K.
Mon, 20 Jan	09:00 — 13:00	EXAM	Microprocessor technology	 M18-621  Benesh P.B.
Wed, 22 Jan	09:00 — 13:00	EXAM	Principles of Complex Technical Systems Design. Standardization and Systems of Quality Assurance.	 M19-601  Erofeeva T.K., Ulyanin O.V.
Fri, 24 Jan	09:00 — 13:00	EXAM	Thermal fields in the device engineering, thermal exposure and testing	 M18-621  Antropov D.S.